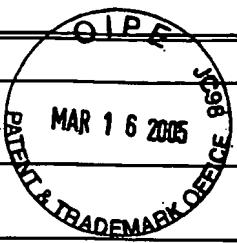


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U.S. DEPARTMENT OF COMMERCE
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Date Submitted to PTO: March 16, 2005

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Kouichi TAKAMINE et al.FILING DATE
October 8, 2004GROUP
2155

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			APPLICANT Kouichi TAKAMINE et al.				
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/CN/	AA	6,425,081	7/2002	Iwamura			
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